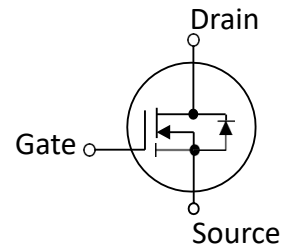
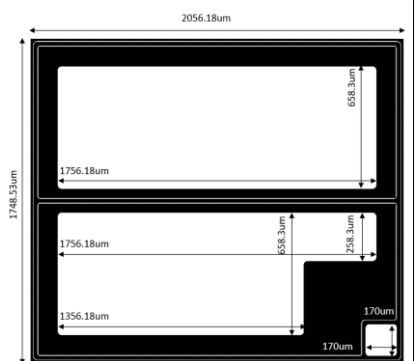


40V N-Channel MOSFET

- Advanced Split Gate Device Design and Processes
- High Reliability Capability
- Sampled CP Probing

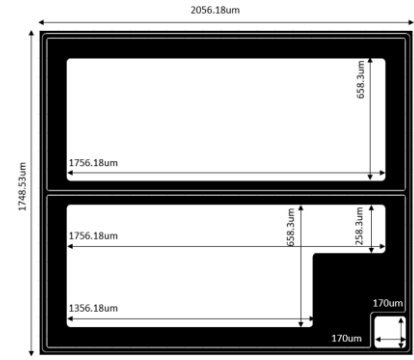
SYMBOL

Electrical Characteristics in C/P Test (T_J at 25 °C)

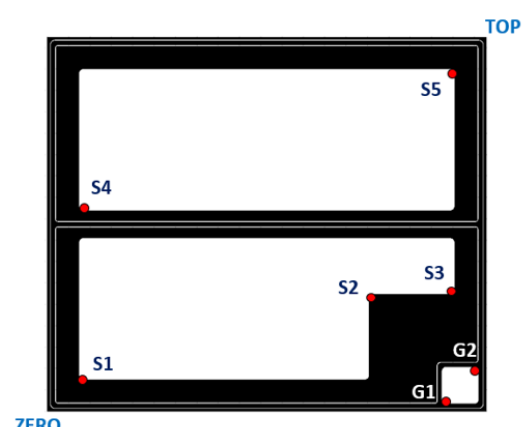
Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Condition
V _{(BR)DSS}	Drain-Source Breakdown Voltage	40	—	—	V	V _{GS} = 0V, I _D = 250μA
R _{DS(ON)}	Static Drain-Source On-Resistance	—	2	2.5	mΩ	V _{GS} = 10V, I _D = 1A ⁽¹⁾
V _{GS(th)}	Gate Threshold Voltage	2	—	4	V	V _{DS} = V _{GS} , I _D = 250μA
I _{DSS}	Drain-to-Source Leakage Current	—	—	1	μA	V _{DS} = 40V, V _{GS} = 0V
I _{GSS}	Gate-to-Source Leakage Current	100	—	100	nA	V _{DS} = 0V, V _{GS} = ±20V
T _J , T _{STG}	Operating and Storage Temperature	-55°C to 150°C Max.				

Mechanical Data		Die Drawing
Chip Size ⁽²⁾	2056 μm X 1748 μm	
Gate Pad Size	170 μm X 170 μm	
Source Pad Size ⁽¹⁾	1756 μm X 658 μm (2 Pads)	
Scribe Line Width	60 μm	
Wafer Thickness	100 μm	
Wafer Diameter	200 mm	
Gross Die	7512 EA	
Source Metallization	Al-Cu (4μm typical)	
Drain Metallization	Ti-Ni-Ag	
Passivation	SiN	
Recommended Storage Environment	Store in original container, in dry nitrogen, 6 months at ambient temperature of 23°C ± 3°C	

(1) Pulse Width tp = < 1 mS, Duty Cycle < 2%.

(2) Chip size not include scribe line.

Specific Assembly Information Bill of Material (BOM)		Die Drawing
Package Type	DFN5*6	
Die Attach Method	Soft solder	
Soft Solder Composition	Pb,Sn,Ag	
Gate Wire Bonding	Cu, 2 mil x 1	
Source Wire Bonding	Al Ribbon	
Molding Compound Manufacturer	G700HF	
Solder Plating Composition	Pure Tin	

Position			Bonding Diagram Top View
	X (μm)	Y (μm)	
ZERO	0	0	
TOP	2056.18	1748.53	
S1	150	150	
S2	1506.18	550	
S3	1906.18	808.3	
S4	150	940.23	
S5	1906.18	1598.53	
G1	1849.63	36.7	
G2	2019.63	206.7	

Electrical Characteristics in F/T Test (T_J at 25 °C)						
Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Condition
I _{DSS}	Drain-to-Source Leakage Current	—	—	1	μA	V _{DS} =40V, V _{GS} =0V
I _{GSSF}	Gate-to-Source Leakage Current	—	—	100	nA	V _{DS} =0V, V _{GS} =+20V
I _{GSSR}	Gate-to-Source Leakage Current	-100	—	—	nA	V _{DS} =0V, V _{GS} =-20V
BV _{DSS}	Drain-Source Breakdown Voltage	40	—	—	V	V _{GS} =0V, I _D =250μA
BV _{DSS}	Drain-Source Breakdown Voltage	40	—	—	V	V _{GS} =0V, I _D =1mA
R _{DS(ON)}	Static Drain-Source On-Resistance	—	—	3.5	mΩ	V _{GS} =10V, I _D =20A
V _{GS(th)}	Gate Threshold Voltage	2	—	4	V	V _{DS} =V _{GS} , I _D =250μA
V _{SD}	Body Diode Forward Voltage	—	—	1.2	V	V _{GS} =0V, I _{SD} =20A
I _{AS}	Avalanche Current				A	V _{DD} =40V, V _{GS} =10V, R _G =25Ω, L=0.1mH
T _J , T _{STG}	Operating and Storage Temperature	-55	—	150	°C	

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